

Notice of References Cited	Application/Control No.	Applicant(s)/Patent Under Reexamination LAI, YAW-HUEY	
	Examiner Ross N. Gushi	Art Unit 2833	Page 1 of 1

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	M	US-			

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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